



#### COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

### **Product Summary**

Device	BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
NI Observati	00)/	50mΩ @ V <sub>GS</sub> = 10V	4.6A
N-Channel	30V	90mΩ @ V <sub>GS</sub> = 4.5V	3.4A
D. Ohaaraal	001/	$95mΩ @ V_{GS} = -10V$	-3.3A
P-Channel	-30V	140mΩ @ V <sub>GS</sub> = -4.5V	-2.7A

#### **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

#### **Description**

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

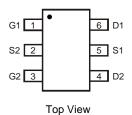
- Backlighting
- DC-DC Converters
- Power Management Functions

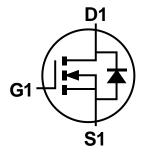
#### **Mechanical Data**

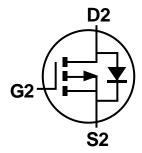
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208@3
- Weight: 0.013 grams (Approximate)











Q1 N-Channel MOSFET

Q2 P-Channel MOSFET

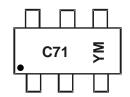
#### Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3071LVT-7	TSOT26	3000 / Tape & Reel
DMC3071LVT-13	TSOT26	10000 / Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

### **Marking Information**



C71 = Product Type Marking Code YM = Date Code Marking Y or  $\overline{Y}$  = Year (ex: F = 2018) M or  $\overline{M}$  = Month (ex: 9 = September)

Date Code Key

Year	2017		2018	2019		2020	2021		2022	2023		2024
Code	Е		F	G		Н	I		J	K		L
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** $(@T_A = +25^{\circ}C, \text{ unless otherwise specified.})$

Characteristic	Symbol	Q1 Value	Q2 Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	30	-30	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	±20	V		
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	4.6 3.6	-3.3 -2.6	Α
Maximum Continuous Body Diode Forward Current	I <sub>S</sub>	1.5	-1.3	Α		
Pulsed Drain Current (380µs Pulse, Duty Cycle = 19	I <sub>DM</sub>	20	-10	Α		

### **Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	$P_{D}$	0.7	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	186	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	$P_{D}$	1.1	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	117	°C/W
Thermal Resistance, Junction to Case		$R_{\theta JC}$	45	C/VV
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

# Electrical Characteristics Q1 N-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1.0	μΑ	$V_{DS} = 30V$ , $V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.0	_	2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	В		34	50	mΩ	$V_{GS} = 10V, I_D = 3.5A$
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>		44	90	11177	$V_{GS} = 4.5V, I_D = 2.0A$
Diode Forward Voltage	$V_{SD}$	_	0.8	1.0	V	$V_{GS} = 0V$ , $I_S = 1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	Ciss	_	190	_		4514.14
Output Capacitance	Coss	-	36	_	pF	$V_{DS} = 15V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	26	_		
Gate Resistance	$R_{g}$	-	4.2	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	2.1	_		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	4.5	_	nC	\\\\ 45\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Gate-Source Charge	$Q_{gs}$	_	0.5	_	IIC	$V_{DS} = 15V, I_D = 4A$
Gate-Drain Charge	$Q_{gd}$	_	0.8	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	1.7	_		
Turn-On Rise Time	t <sub>R</sub>	_	5.7	_	ns	$V_{DS} = 15V, V_{GS} = 10V,$
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	6.0	_	ns	$R_G = 3\Omega$ , $I_D = 4A$
Turn-Off Fall Time	t <sub>F</sub>	_	1.6	_		
Reverse Recovery Time	t <sub>RR</sub>	_	4.2	_	ns	1 44 11/11 4004/1-
Reverse Recovery Charge	$Q_{RR}$	_	0.5	_	nC	I <sub>F</sub> = 4A, di/dt = 100A/μs

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

<sup>6.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.7. Short duration pulse test used to minimize self-heating effect.

<sup>8.</sup> Guaranteed by design. Not subject to production testing.



## Electrical Characteristics Q2 P-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

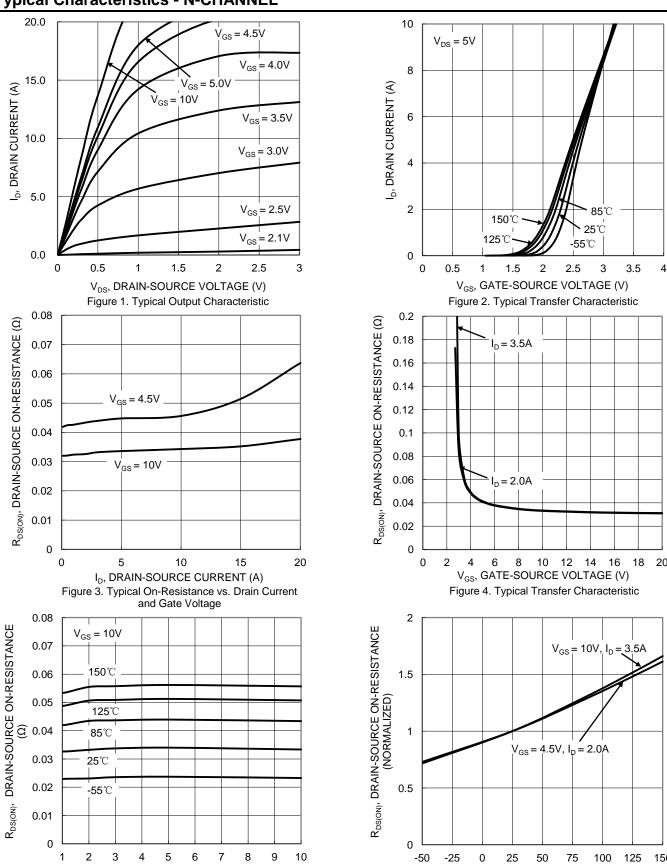
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	_	_	V	$V_{GS} = 0V, I_{D} = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1.0	μA	$V_{DS} = -30V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-1	1	-2.5	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance			83	95	mΩ	$V_{GS} = -10V, I_D = -3.8A$	
Static Diani-Source On-Resistance	R <sub>DS(ON)</sub>	_	128	140	11122	$V_{GS} = -4.5V, I_D = -3.0A$	
Diode Forward Voltage	$V_{SD}$	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	_	254	_		V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Output Capacitance	Coss	_	14	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	7	_		1 - 1.01/11/12	
Gate Resistance	Rg	_	54	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	$Q_g$	_	3.1	_			
Total Gate Charge (V <sub>GS</sub> = -10V)	Qg	_	6.5	_	~C	V 45V L 200	
Gate-Source Charge	Qgs	_	0.8	_	nC	$V_{DS} = -15V, I_D = -3.8A$	
Gate-Drain Charge	$Q_{qd}$	_	1.4	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	3.5	_			
Turn-On Rise Time	t <sub>R</sub>	_	6.2	_		$V_{GS} = -10V, V_{DS} = -15V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	21.8	_	ns	$R_G = 6\Omega$ , $R_L = 15\Omega$	
Turn-Off Fall Time	t <sub>F</sub>	_	13.1	_			
Reverse Recovery Time	t <sub>RR</sub>	_	9.6	_	ns	$I_F = -1.0A$ , $di/dt = -100A/\mu s$	
Reverse Recovery Charge	Q <sub>RR</sub>		2.4	_	nC	I <sub>F</sub> = -1.0A, di/dt = -100A/µs	

Notes:

<sup>7.</sup> Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing.



### **Typical Characteristics - N-CHANNEL**



 $T_J$ , JUNCTION TEMPERATURE (°C)

Figure 6. On-Resistance Variation with Junction

Temperature

I<sub>D</sub>, DRAIN CURRENT (A)

Figure 5. Typical On-Resistance vs. Drain Current

and Junction Temperature



## Typical Characteristics - N-CHANNEL (Cont.)

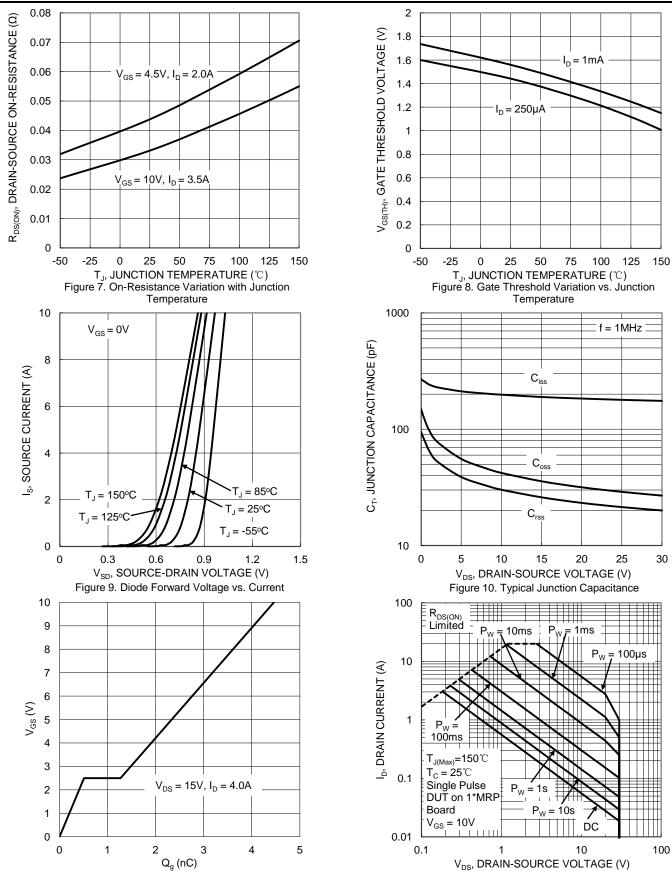
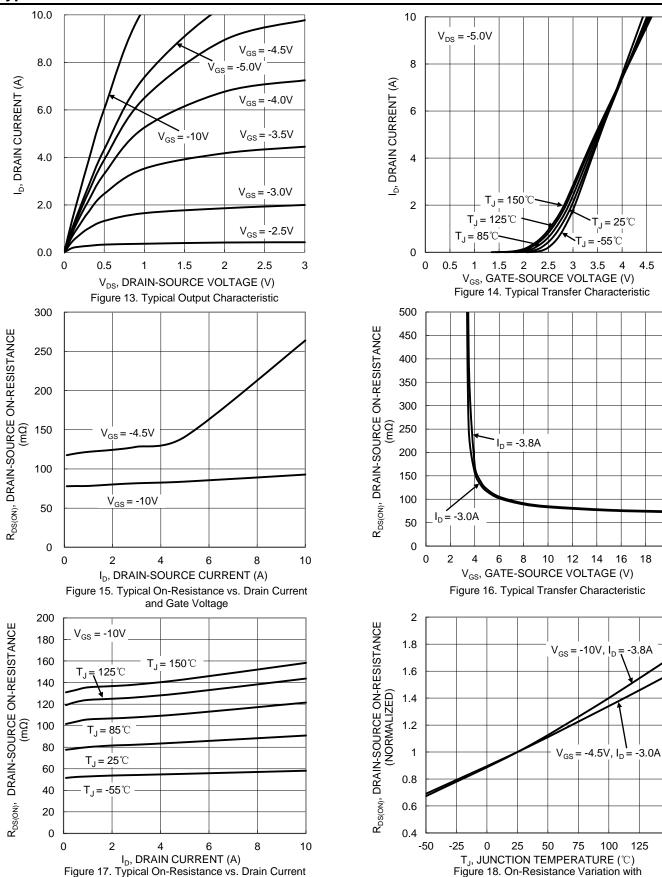


Figure 11. Gate Charge

Figure 12. SOA, Safe Operation Area



### Typical Characteristics - P-CHANNEL



and Temperature

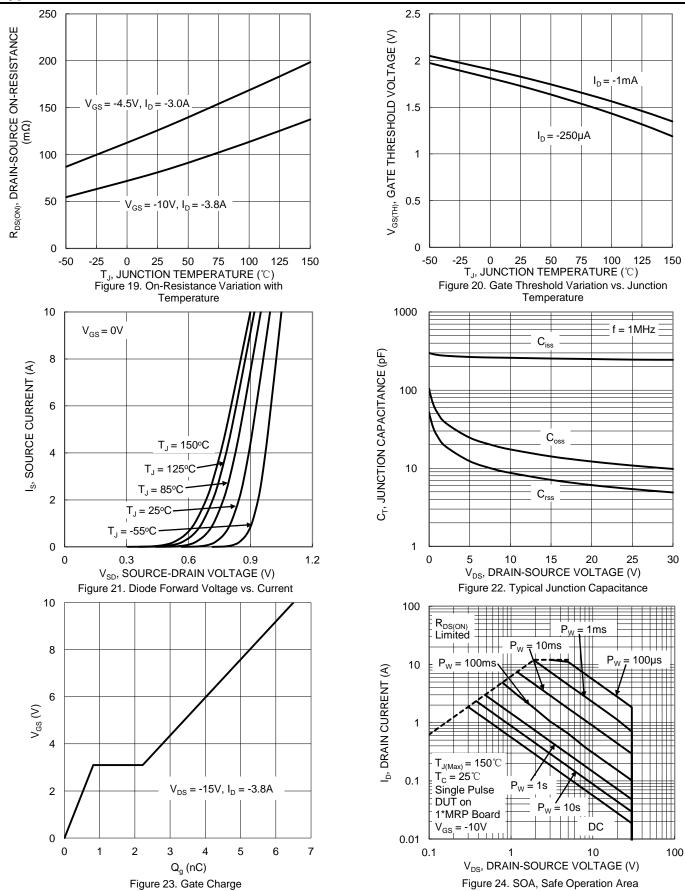
Temperature

150

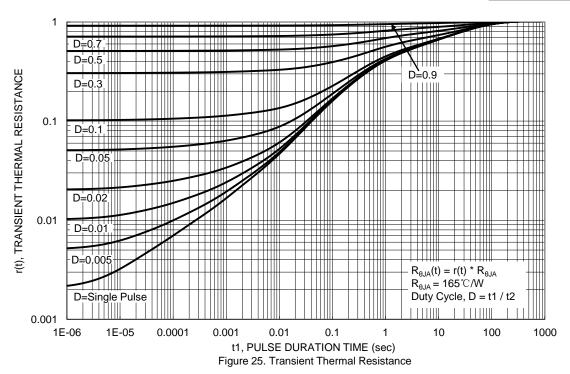
18



## Typical Characteristics - P-CHANNEL (Cont.)







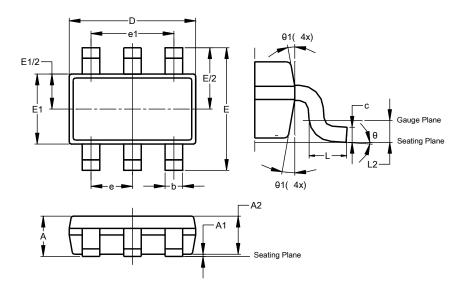
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# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### TSOT26

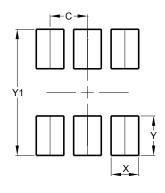


	TSOT26							
Dim	Min	Max	Тур					
Α	-	1.00	_					
A1	0.010	0.100	_					
A2	0.840	0.900	_					
D	2.800	3.000	2.900					
Е	2.800 BSC							
E1	1.500	1.700	1.600					
b	0.300	0.450	-					
С	0.120	0.200	_					
е	C	.950 BS	C					
e1	1	.900 BS	C					
L	0.30	0.50	_					
L2	0.250 BSC							
θ	0°	8°	4°					
θ1	4°	12°	_					
Α	II Dimen	sions in	mm					

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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